UHF power LDMOS transistor Rev. 3 — 30 August 2011

Product data sheet

Product profile 1.

1.1 General description

A 600 W LDMOS RF power transistor for broadcast transmitter applications and industrial applications. The excellent ruggedness of this device makes it ideal for digital and analog transmitter applications.

Application information Table 1.

RF performance at $V_{DS} = 50$ V unless otherwise specified.

Mode of operation	f	P _{L(AV)}	P _{L(M)}	Gp	η_D	IMD3	IMD _{shldr}	PAR
	(MHz)	(W)	(W)	(dB)	(%)	(dBc)	(dBc)	(dB)
RF performance in a co	mmon source 860 MHz n	arrowband	test circ	uit				
2-tone, class-AB	f ₁ = 860; f ₂ = 860.1	250	-	21	46	-32	-	-
pulsed, class-AB [1]	860	-	600	20	58	-	-	-
DVB-T (8k OFDM)	858	110	-	21	31	-	-32 [2]	8.2 <mark>3</mark>
	858	125	-	21	32.5	-	-30 [2]	8.0 <mark>[3]</mark>
RF performance in a co	ommon source 470 MHz to	o 860 MHz I	oroadbai	nd test o	ircuit			
DVB-T (8k OFDM)	858	110	-	20	30	-	-32 [2]	8.0 <mark>[3]</mark>
	858	120	-	20	31	-	-31 [2]	7.8 <mark>3</mark>

[1] Measured at δ = 10 %; t_p = 100 µs.

[2] Measured [dBc] with delta marker at 4.3 MHz from center frequency.

[3] PAR (of output signal) at 0.01 % probability on CCDF; PAR of input signal = 9.5 dB at 0.01 % probability on CCDF.

1.2 Features and benefits

- Excellent ruggedness (VSWR ≥ 40 : 1 through all phases)
- Optimum thermal behavior and reliability, R_{th(i-c)} = 0.15 K/W
- High power gain
- High efficiency
- Designed for broadband operation (470 MHz to 860 MHz)
- Internal input matching for high gain and optimum broadband operation
- Excellent reliability
- Easy power control
- Compliant to Restriction of Hazardous Substances (RoHS) Directive 2002/95/EC

1.3 Applications

- Communication transmitter applications in the UHF band
- Industrial applications in the UHF band



UHF power LDMOS transistor

2. Pinning information

Pin	Description	Simplified outline	Graphic symbol
BLF888A	A (SOT539A)		
1	drain1		
2	drain2		
3	gate1	5	
4	gate2		
5	SOUICE	<u>[1]</u>	2 sym117
BLF888A	AS (SOT539B)		
1	drain1	4 0	4
2	drain2		۲ لــــا
3	gate1	5	
4	gate2	3 4	
5	source	<u>[1]</u>	

[1] Connected to flange.

3. Ordering information

Table 3.Ordering information

Type number	Package					
	Name	Description	Version			
BLF888A	-	flanged balanced LDMOST ceramic package; 2 mounting holes; 4 leads	SOT539A			
BLF888AS	-	earless flanged balanced LDMOST ceramic package; 4 leads	SOT539B			

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

			,		
Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage		-	110	V
V _{GS}	gate-source voltage		-0.5	+11	V
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	200	°C

2 sym117

5. Thermal characteristics

Table 5.	Thermal characteristics				
Symbol	Parameter	Conditions	٦	Тур	Unit
R _{th(j-c)}	thermal resistance from junction to case	T_{case} = 80 °C; $P_{L(AV)}$ = 125 W	<u>[1]</u> (0.15	K/W
[1] R _{th(j-c)}	is measured under RF conditions.				

6. Characteristics

Table 6. DC characteristics

 $T_i = 25$ °C; per section unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{(BR)DSS}	drain-source breakdown voltage	V_{GS} = 0 V; I_D = 2.4 mA	[1]	110	-	-	V
V _{GS(th)}	gate-source threshold voltage	V_{DS} = 10 V; I_{D} = 240 mA	[1]	1.4	1.9	2.4	V
I _{DSS}	drain leakage current	V_{GS} = 0 V; V_{DS} = 50 V		-	-	2.8	μA
I _{DSX}	drain cut-off current	$\label{eq:VGS} \begin{array}{l} V_{GS} = V_{GS(th)} + 3.75 \text{ V}; \\ V_{DS} = 10 \text{ V} \end{array}$		-	36	-	A
I _{GSS}	gate leakage current	$V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}$		-	-	280	nA
R _{DS(on)}	drain-source on-state resistance	$\label{eq:VGS} \begin{split} V_{GS} &= V_{GS(th)} + 3.75 \text{ V};\\ I_D &= 8.5 \text{ A} \end{split}$	[1]	-	143	-	mΩ
C _{iss}	input capacitance	$V_{GS} = 0 V; V_{DS} = 50 V;$ f = 1 MHz	[2]	-	220	-	pF
C _{oss}	output capacitance	$V_{GS} = 0 V; V_{DS} = 50 V;$ f = 1 MHz		-	74	-	pF
C _{rss}	reverse transfer capacitance	$V_{GS} = 0 V; V_{DS} = 50 V;$ f = 1 MHz		-	1.2	-	pF

[1] I_D is the drain current.

[2] Capacitance values without internal matching.

Table 7.RF characteristics

RF characteristics in NXP production narrowband test circuit; $T_{case} = 25 \ ^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
2-Tone, c	ass-AB						
V _{DS}	drain-source voltage			-	50	-	V
I _{Dq}	quiescent drain current		[1]	-	1.3	-	А
$P_{L(AV)}$	average output power	f ₁ = 860 MHz; f ₂ = 860.1 MHz		250	-	-	W
G _p	power gain	f ₁ = 860 MHz; f ₂ = 860.1 MHz		20	21	-	dB
η_D	drain efficiency	f ₁ = 860 MHz; f ₂ = 860.1 MHz		42	46	-	%
IMD3	third-order intermodulation distortion	f ₁ = 860 MHz; f ₂ = 860.1 MHz		-	-32	-28	dBc

BLF888A_BLF888AS
Product data sheet

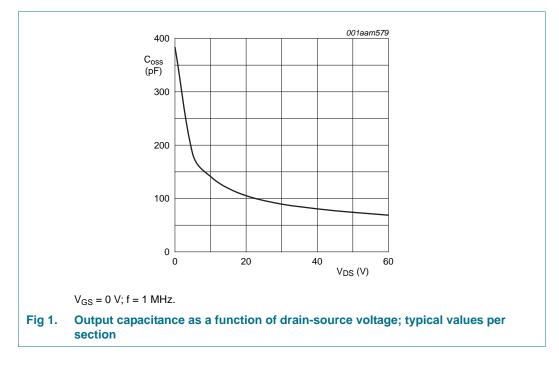
Table 7. RF characteristics ...continued

RF characteristics in NXP production narrowband test circuit; $T_{case} = 25$ °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
DVB-T (8	k OFDM), class-AB						
V _{DS}	drain-source voltage			-	50	-	V
I _{Dq}	quiescent drain current		[1]	-	1.3	-	А
P _{L(AV)}	average output power	f = 858 MHz		110	-	-	W
G _p	power gain	f = 858 MHz		20	21	-	dB
η_D	drain efficiency	f = 858 MHz		28	31	-	%
IMD _{shldr}	intermodulation distortion shoulder	f = 858 MHz	[2]	-	-32	-28	dBc
PAR	peak-to-average ratio	f = 858 MHz	[3]	-	8.2	-	dB

[1] I_{Dq} for total device.

- [2] Measured [dBc] with delta marker at 4.3 MHz from center frequency.
- [3] PAR (of output signal) at 0.01 % probability on CCDF; PAR of input signal = 9.5 dB at 0.01 % probability on CCDF.



6.1 Ruggedness in class-AB operation

The BLF888A and BLF888AS are capable of withstanding a load mismatch corresponding to VSWR ≥ 40 : 1 through all phases under the following conditions: V_{DS} = 50 V; f = 860 MHz at rated power.

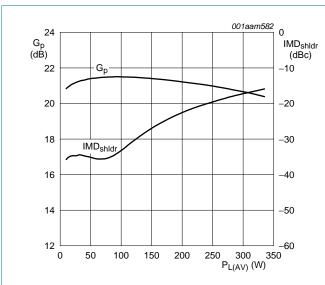
7. Application information

001aan762 0 001aan761 60 24 24 G_p (dB) η_D (%) G_p (dB) IMD3 Gp Gp (dBc) 40 -20 20 20 ηD İMD3 16 20 16 -40 12 0 12 -60 00 500 P_{L(AV)} (W) 00 500 P_{L(AV)} (W) 0 100 200 300 400 0 100 200 300 400 V_{DS} = 50 V; I_{Dq} = 1.3 A; measured in a common source V_{DS} = 50 V; I_{Dq} = 1.3 A; measured in a common source narrowband 860 MHz test circuit. narrowband 860 MHz test circuit. Fig 2. 2-Tone power gain and drain efficiency as Fig 3. 2-Tone power gain and third order function of load power; typical values intermodulation distortion as load power; typical values

7.1 Narrowband RF figures

7.1.1 2-Tone

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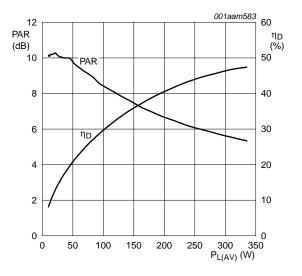


7.1.2 DVB-T

 V_{DS} = 50 V; I_{Dq} = 1.3 A; measured in a common source narrowband 860 MHz test circuit.

Fig 4. **DVB-T** power gain and intermodulation distortion shoulder as function of load power; typical values

7.2 Broadband RF figures



 V_{DS} = 50 V; I_{Dq} = 1.3 A; measured in a common source narrowband 860 MHz test circuit.

001aam584

50

40

30

20

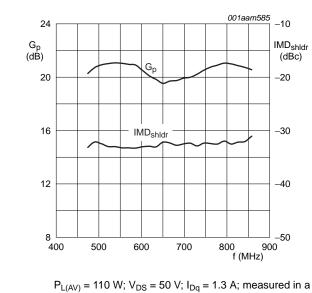
10

900

η_D

(%)

Fia 5. DVB-T peak-to-average ratio and drain efficiency as function of load power; typical values



DVB-T power gain and intermodulation

distortion shoulder as a function of frequency;

7.2.1 DVB-T

5.5 L 400 500 600 700 800 f (MHz) $P_{L(AV)}$ = 110 W; V_{DS} = 50 V; I_{Dq} = 1.3 A; measured in a common source broadband test circuit as described in

9.5

8.5

7.5

6.5

PAR

(dB)

common source broadband test circuit as described in Section 8.

PAR

 η_{D}



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Fig 6.

BLF888A BLF888AS

Section 8.

typical values

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7.3 Impedance information

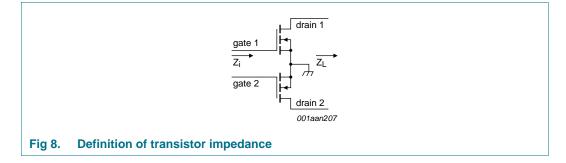


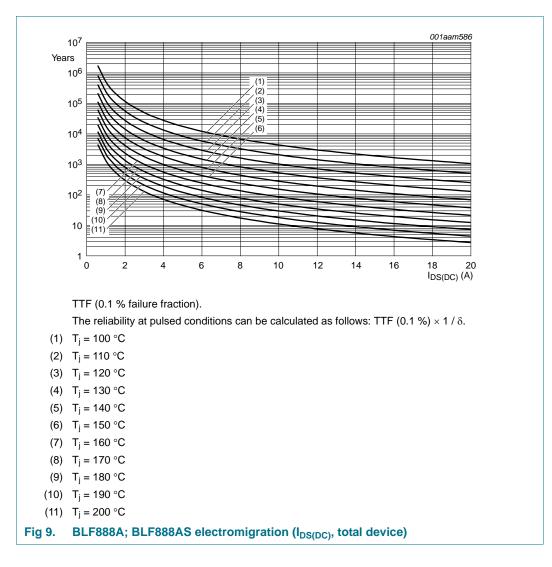
Table 8. Typical push-pull impedance

Simulated Z_i and Z_L device impedance; impedance info at $V_{DS} = 50$ V and $P_{L(AV)} = 110$ W (DVB-T).

f	Zi	ZL
MHz	Ω	Ω
300	0.617 – j1.715	4.989 + j1.365
325	0.635 – j1.355	4.867 + j1.424
350	0.655 – j1.026	4.741 + j1.472
375	0.677 – j0.721	4.614 + j1.511
400	0.702 - j0.435	4.486 + j1.540
425	0.731 – j0.164	4.357 + j1.559
450	0.762 + j0.096	4.228 + j1.570
475	0.798 + j0.347	4.100 + j1.573
500	0.839 + j0.592	4.974 + j1.567
525	0.884 + j0.833	3.850 + j1.554
550	0.936 + j1.072	3.728 + j1.534
575	0.995 + j1.310	3.608 + j1.508
600	1.063 + j1.549	3.492 + j1.475
625	1.141 + j1.791	3.378 + j1.437
650	1.230 + j2.037	3.268 + j1.394
675	1.334 + j2.289	3.161 + j1.347
700	1.456 + j2.548	3.057 + j1.295
725	1.599 + j2.814	2.957 + j1.239
750	1.768 + j3.090	2.860 + j1.180
775	1.971 + j3.376	2.676 + j1.118
800	2.214 + j3.671	2.677 + j1.053
825	2.510 + j3.975	2.591 + j0.985
850	2.873 + j4.282	2.508 + j0.915
875	3.320 + j4.584	2.428 + j0.843
900	3.875 + j4.865	2.351 + j0.770
925	4.562 + j5.095	2.277 + j0.695
950	5.409 + j5.223	2.206 + j0.618
975	6.426 + j5.166	2.138 + j0.540
1000	7.587 + j4.807	2.073 + j0.461

UHF power LDMOS transistor

7.4 Reliability



8. Test information

Table 9. List of components For test circuit, see Figure 10, Figure 11 and Figure 12. Component Description Value Remarks B1, B2 semi rigid coax 25 Ω; 49.5 mm UT-090C-25 (EZ 90-25) [1] C1 multilayer ceramic chip capacitor 12 pF [1] C2, C3, C4, C5, multilayer ceramic chip capacitor 8.2 pF C6 C7 multilayer ceramic chip capacitor 6.8 pF [2] [2] C8 multilayer ceramic chip capacitor 2.7 pF [2] C9 2.2 pF multilayer ceramic chip capacitor C10, C13, C14 100 pF [3] multilayer ceramic chip capacitor C11, C12 [2] multilayer ceramic chip capacitor 10 pF Kemet C1210X475K5RAC-TU or C15, C16 4.7 μF, 50 V multilayer ceramic chip capacitor capacitor of same quality. 100 pF [2] C17, C18, C23, multilayer ceramic chip capacitor C24 C19, C20 TDK C570X7R1H106KT000N or multilayer ceramic chip capacitor 10 µF, 50 V capacitor of same quality. C21, C22 470 μF; 63 V electrolytic capacitor [4] C30 multilayer ceramic chip capacitor 10 pF [4] C31 multilayer ceramic chip capacitor 9.1 pF [4] C32 multilayer ceramic chip capacitor 3.9 pF [4] C33, C34, C35 multilayer ceramic chip capacitor 100 pF TDK C4532X7R1E475MT020U or C36. C37 multilayer ceramic chip capacitor 4.7 μF, 50 V capacitor of same quality. L1 [5] (W \times L) 15 mm \times 13 mm microstrip _ L2 [5] $(W \times L) 5 \text{ mm} \times 26 \text{ mm}$ microstrip L3. L32 [5] $(W \times L) 2 \text{ mm} \times 49.5 \text{ mm}$ microstrip _ [5] L4 microstrip $(W \times L)$ 1.7 mm 3.5 mm _ L5 [5] $(W \times L) 2 \text{ mm} \times 9.5 \text{ mm}$ microstrip -L30 [5] $(W \times L) 5 \text{ mm} \times 13 \text{ mm}$ microstrip -L31 microstrip _ [5] $(W \times L) 2 \text{ mm} \times 11 \text{ mm}$ L33 [5] $(W \times L) 2 mm \times 3 mm$ microstrip -R1, R2 **10** Ω wire resistor R3, R4 SMD resistor 5.6 Ω 0805 R5. R6 wire resistor **100** Ω R7, R8 potentiometer 10 kΩ

[1] American technical ceramics type 800R or capacitor of same quality.

[2] American technical ceramics type 800B or capacitor of same quality.

[3] American technical ceramics type 180R or capacitor of same quality.

[4] American technical ceramics type 100A or capacitor of same quality.

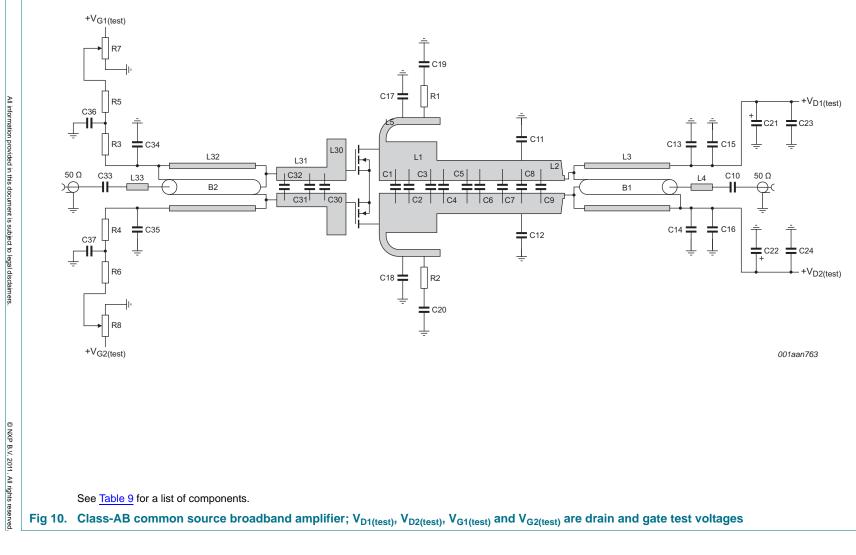
[5] Printed-Circuit Board (PCB): Taconic RF35; ε_r = 3.5 F/m; height = 0.762 mm; Cu (top/bottom metallization); thickness copper plating = 35 μ m.

BLF888A BLF888AS

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BLF888A_BLF888AS Product data sheet





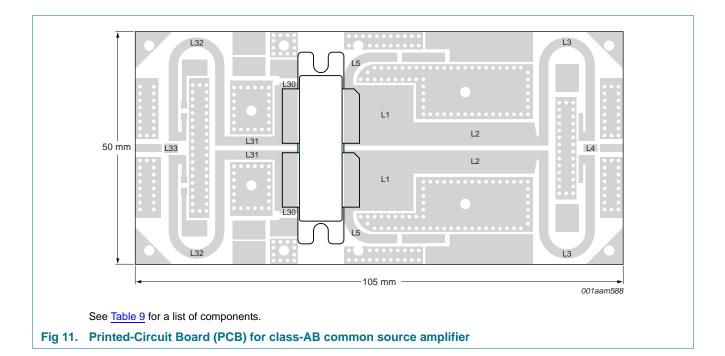
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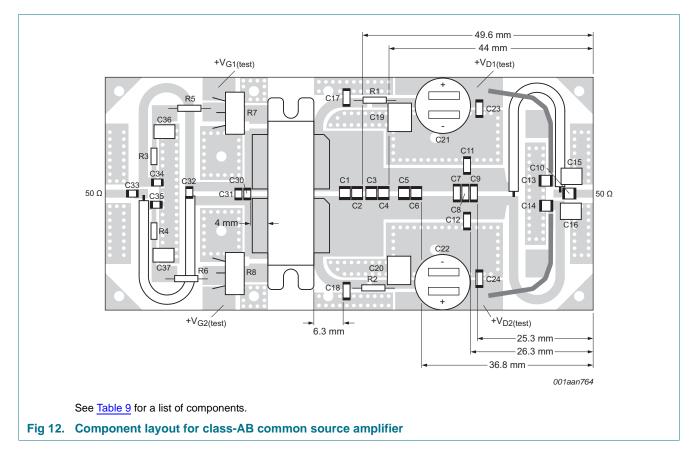
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BLF888A; BLF888AS

UHF power LDMOS transistor





UHF power LDMOS transistor

9. Package outline

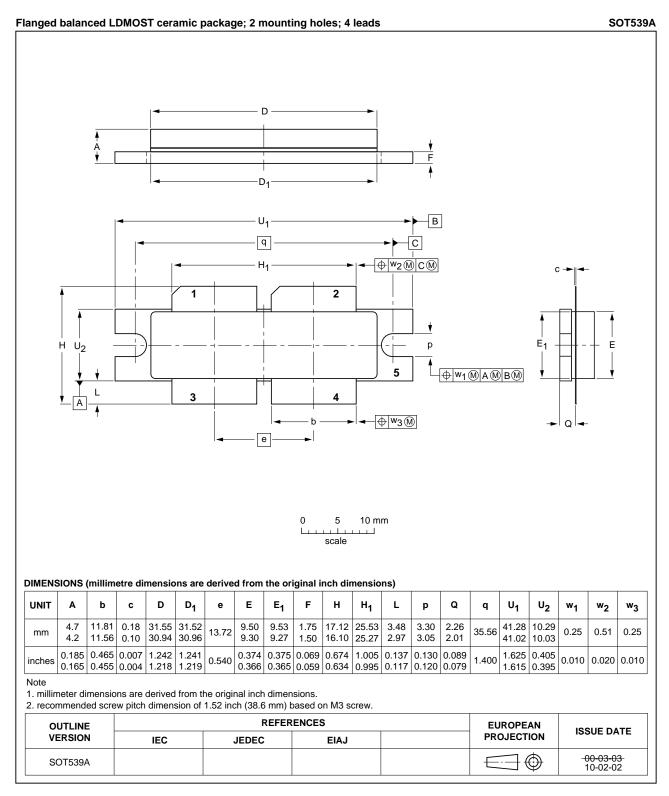


Fig 13. Package outline SOT539A

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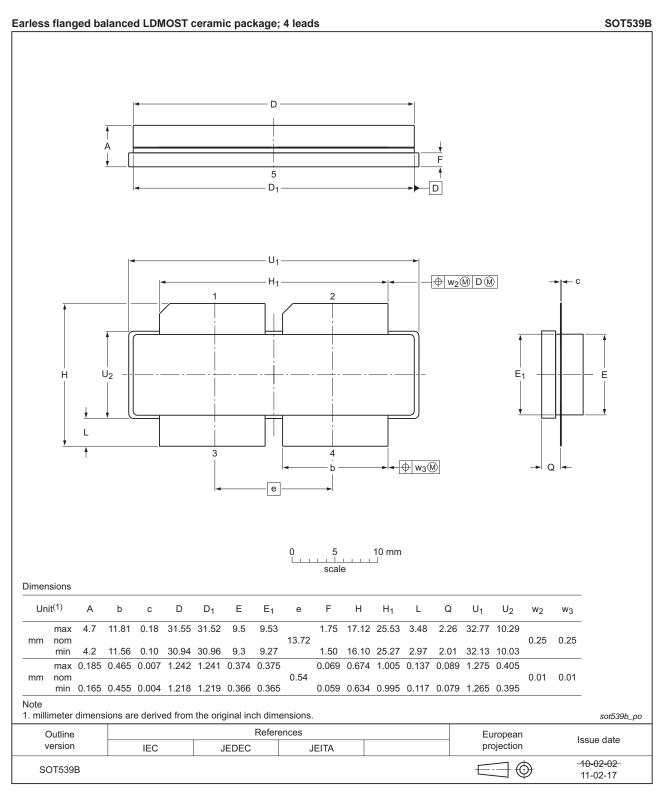


Fig 14. Package outline SOT539B

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10. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

11. Abbreviations

Table 10. A	Abbreviations
Acronym	Description
CCDF	Complementary Cumulative Distribution Function
DVB	Digital Video Broadcast
DVB-T	Digital Video Broadcast - Terrestrial
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
LDMOST	Laterally Diffused Metal-Oxide Semiconductor Transistor
OFDM	Orthogonal Frequency Division Multiplexing
PAR	Peak-to-Average power Ratio
RF	Radio Frequency
SMD	Surface Mounted Device
UHF	Ultra High Frequency
VSWR	Voltage Standing-Wave Ratio

12. Revision history

Table 11. Revision histo	ory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF888A_BLF888AS v.3	20110830	Product data sheet	-	BLF888A_BLF888AS v.2
Modifications:	 The status 	of this document has been	changed to Product	data sheet.
	• <u>Table 7 on</u> removed.	page 3: The values in the C	onditions column fo	r V_{DS} and I_{Dq} have been
BLF888A_BLF888AS v.2	20110301	Preliminary data sheet	-	BLF888A_BLF888AS v.1
BLF888A_BLF888AS v.1	20100921	Objective data sheet	-	-

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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